## Search Notes



App	licat	ion/	Conf	trol	No
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09972229

Examiner

Shiferaw, Eleni A

Applicant(s)/Patent Under Reexamination

Art Unit

WEE ET AL.

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## **SEARCHED**

Class	Subclass	Date	Examiner
380	37	9/6/07	ES
380	200	12/27/04	ES
380	267	9/6/07	ES
380	217	9/6/07	ES

## **SEARCH NOTES**

Search Notes	Date	Examiner
East searched and updated on 5/13/05, 11/1/05, 3/6/05, and 9/7/07	12/27/04	es
NPL: IEEE ((progressive image metadata) (different encryption method metadata)) •	5/13/05	es
380/201 and text searched	9/7/07	es

## INTERFERENCE SEARCH

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		
380	37, 200, 201, 217, and 269	9/7/07	es		
please see the searched report attached for interference searched on class/subclas s and text searched		9/7/07	es		

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